



Express analyzer configurations

- Basic Analyzer Express Option BAS
- Standard Analyzer Express Option STD
- Communications Test Analyzer
 Express Option COM

Agilent ESA Series Spectrum Analyzers

Data Sheet

The ESA family of spectrum analyzers have proven and guaranteed performance with the flexibility to select the right level of functionality for your test needs. Take advantage of the best overall performance on a mid-performance spectrum analyzer.

Industry best typical performance

- Warm up time: 5 minutes
- Third order intermodulation distortion: +16 dBm
- Sensitivity: -166 dBm
- Amplitude accuracy: ± 0.4 dB
- Overall phase noise (all carrier frequencies^a):
 - -101 dBc/Hz (10 kHz)
 - -122 dBc/Hz (100 kHz)
 - -136 dBc/Hz (1 MHz)

a. Add 20LogN for frequencies > 6.7 GHz, where N is the harmonic mixing mode.



Definitions and Conditions

The distinction between specifications and characteristics is described as follows.

- Specifications describe the performance of parameters covered by the product warranty. (The temperature range is 0 °C to 55 °C, unless otherwise noted.)
- Characteristics describe product performance that is useful in the application of the product, but is not covered by the product warranty.
- Typical performance describes additional product performance information that is not covered by the product warranty. It is performance beyond specification that 80% of the units exhibit with a 95% confidence level over the temperature range 20 to 30 °C. Typical performance does not include measurement uncertainty.
- Nominal values indicate the expected performance, or describe product performance that is useful in the application of the product, but is not covered by the product warranty.
- N/A (not applicable) Not specified for this configuration

The following conditions must be met for the analyzer to meet its specifications.

- The analyzer is within the one year calibration cycle.
- If Auto Align All is selected:
 - After 2 hours of storage within the operating temperature range.
 - 5 minutes after the analyzer is turned on with sweep times less than 4 seconds.
- If Auto Align Off is selected:
 - When the analyzer is at a constant temperature, within the operating temperature range, for a minimum of 90 minutes.
 - After the analyzer is turned on for a minimum of 90 minutes and **Align Now All** has been run.
 - When **Align Now All** is run:
 - Every hour
 - If the ambient temperature changes more than 3 $^{\circ}\mathrm{C}$
 - If the 10 MHz reference changes
- If Auto Align All but RF is selected:
 - When the analyzer is at a constant temperature, within the operating temperature range, for a minimum of 90 minutes.
 - After the analyzer is turned on for a minimum of 90 minutes and **Align Now RF** has been run.
 - When **Align Now RF** is run:
 - Every hour
 - If the ambient temperature changes more than 3 $^{\circ}\mathrm{C}$
- 2

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BAS configuration	9 kHz - 1.5 GHz	9 kHz - 3 GHz	9 kHz - 26.5 GHz
Custom configuration	(75 Ω input Option 1DP) 1 MHz - 1.5 GHz	N/A	N/A

Frequency range	E4402B	E4404B	E4405B	E4407B		
STD or COM configuration	9 kHz - 3 GHz	9 kHz – 6.7 GHz	9 kHz – 13.2 GHz	9 kHz - 26.5 GHz		
Low frequency extension Optio	Low frequency extension Option UKB					
Custom configuration	100 Hz ^a - 3 GHz	100Hz ^a - 6.7 GHz	100Hz ^a - 13.2 GHz	100Hz ^a - 26.5 GHz External mixing Option AYZ Add 18 GHz - 325 GHz		

Frequency range	100 Hz - 3 GHz	2.85 - 6.7 GHz	6.2 - 13.2 GHz	12.8 – 19.2 GHz	18.7 – 26.5 GHz
Band	0	1	2	3	4
Harmonic (N ^b) mixing mode	1-	1-	2-	4-	4-

a.

30 Hz characteristic. N = LO harmonic mixing mode. b.

		Basic analyzer	Standard analyzer	Communications test analyzer or ESA with Option 1D5	
Frequency reference	e				
Frequency referen	ce error $= \pm [(aging rate)]$	x time since last adjust	ment)+ settability + temper	ature stability]	
Frequency readout = ±(frequency indic	accuracy (start, stop, cen ation x frequency referen	nter, marker) ce error + SP ^C +15% of R	BW + 10 Hz + 1 Hz x N ^a)		
			±2 x 10 ⁻⁶ /year		
Aging rate		$\pm 2 ext{ x 10} - 6/$ year	±1 x 10 ⁻⁷ /year	\pm 1 x 10 ⁻⁷ /year	
			(Opt. 1D5)		
			±5 x 10 ⁻⁶ /year		
Temperature stabilit	у	\pm 5 x 10 $^{-6}$ /year	±1 x 10 ⁻⁸ /year ^b	±1 x 10-8/year ^b	
			(Opt. 1D5)		
			±5 x 10 ⁻⁷ /year		
Settability		\pm 5 x 10 $^{-7}$ /year	±1 x 10 ⁻⁸ /year	±1 x 10 ^{—8} /year	
			(Opt. 1D5)		
		0.75 % y anan	[0.5 % + 1/ (sweep	[0.5 % + 1/ (sweep	
Span coefficient (Sl	^c) ^c	0.75 /0 X Span	points —1)] x span	points —1)] x span	
External reference		10 MHz	10 MHz	1 - 30 MHz	
Marker frequency counter ^d					
Accuracy = ±(marker frequency x frequency reference error + counter resolution) Counter resolution = selectable from 1 Hz to 100 kHz					
Frequency span					
Range = 0 Hz (zero span), 100 Hz to maximum frequency range of the analyzer					
Accuracy	Linear scale	1% of span	±[0.5% x span + 2 x span	/(sweep points – 1)]	
,,	Logarithmic scale	N/A	2% of span, nominal		

b. 20 to 30 °C. span
sweep points fixed at 401 for basic analyzer.
d. Not available in RBW < 1 kHz (Option 1DR).

a. N = LO harmonic mixing mode.

b. 20 to 30 °C.

		Basic analyzer	Standard analyzer or ESA with Option AYX	Communications test analyzer or ESA with Option B7D/B7E	
Sweep time an	d trigger				
Span = 0 Hz		4 ms – 4000 s	50 ns ^a – 4000 s	25 ns ^a - 4000 s	
naliye	Span≥100 Hz	4 ms – 4000 s	1 ms– 4	000 s	
Accuracy (Spa	Accuracy (Span = 0 Hz) ± 1%				
		Free Run, Single, Line, Video, Offset, Delayed, External			
Trigger type ^D		N/A	Gate (1D6)		
		N/A		RF burst (B7E)	
Delayed trigger range 1 us to 400 s					
Sweep (trace)	points				
D	Span = 0 Hz	401	2 - 8	192	
Range	Span≥100 Hz	401	101 -	8192	

	Basic analyzer	Standard analyzer	Communications test analyzer or ESA with Option 1DR and 1D5				
Resolution bandwidths (1-3-10 s	Resolution bandwidths (1-3-10 sequence)						
Range							
(-3 dB) (-6 dB EMI)	1 kHz – 5 MHz ^d 9 KHz, 120 kHz	1 kHz – 5 MHz ^d 9 KHz, 120 kHz	1 Hz to 5 MHz ^d 200 Hz, 9 kHz,120 kHz				
With 1DR ^c (-3dB) (-6 dB EMI)	Add 100 Hz, 300 Hz Add 200 Hz	Add 100 Hz, 300 Hz Add 10 Hz - 300 Hz Add 200 Hz Add 200 Hz					
With 1DR and 1D5 ^e	N/A	Add 1 Hz and 3 Hz	Included				
Accuracy							
1 Hz to 300 Hz		± 10%					
1 kHz to 3 MHz		± 15%					
5 MHz	± 30%						
Selectivity (60 dB/3 dB bandwidth	ı ratio)						
100 Hz to 300 Hz	< 5:1 digital, approximately Gaussian						
1 kHz to 5 MHz	< 15:1 synchronously tuned four poles, approximately Gaussian						
Video bandwidths (1-3-10 sequence)							
Range	30 Hz to 3 MHz						
with 1DR		Adds 1, 3, 10 Hz for RBWs less t	han 1 kHz				

a.

Firmware revision A.08.00 and later. e.

b.

 $[\]label{eq:RBW} \begin{array}{l} \mathsf{RBW} \geq 1 \ \mathsf{kHz}, 2 \ \mathsf{sweep points}. \\ \mathsf{TV} \ \mathsf{trigger} \ \mathsf{available} \ \mathsf{with} \ \mathsf{option} \ \mathsf{B7B} \ \mathsf{in} \ \mathsf{custom} \ \mathsf{configuration} \ \mathsf{for} \ \mathsf{ESA-E}. \\ \mathsf{Only} \ \mathsf{available} \ \mathsf{for} \ \mathsf{spans} < \mathsf{5MHz}. \\ \mathsf{For} \ \mathsf{resolution} \ \mathsf{bandwidths} < 1 \ \mathsf{kHz} \ \mathsf{or} > 3 \ \mathsf{MHz}, \ \mathsf{not} \ \mathsf{compatible} \ \mathsf{with} \ \mathsf{the} \ \mathsf{rms} \ \mathsf{detector}. \\ \end{array}$ c. d.

	Basic analyzer			Standard and communications test analyzer	ESA-E	
	E4411B	E4403B/08B	3	E4402B/04B/05B/07B	with Option 120 ^a	
Stability						
Noise sidebands offse	Noise sidebands offset from CW signal with 1 kHz RBW, 30 Hz VBW and sample detector					
Offset from CW signal	t from Spec and <i>typical dBc/Hz applies to all frequencies</i> \leq 6.7 <i>GHz</i> ^{b, c} ignal <i>Italics indicate typical performance</i>					
≥1 kHz	N/A	N/A -78 dBc/Hz (Option 1D5 and 1DR)		-78 dBc/Hz (Option 1D5 and 1DR)	N/A	
≥10 kHz	-93, -95 dBc/Hz	-90, <i>-94 dBc/Hz</i>	Z	-98, - <i>101 dBc/Hz</i> (Option 1D5) ^d	N/A	
≥ 20 kHz	-100, <i>-102 dBc/Hz</i>	-100, <i>-105 dBc/H</i>	lz	-104, <i>-107 dBc/Hz</i>	N/A	
≥ 30 kHz	-104, - <i>106 dBc/Hz</i>	-106, <i>-112 dBc/H</i>	Ιz	-110, - <i>113 dBc/Hz</i>	N/A	
≥ 100 kHz	-113, -116 dBc/Hz	-118, -122 dBc/H	Ηz	-118, - <i>122 dBc/Hz</i>	N/A	
≥1 MHz	N/A	N/A		-125, -127 dBc/Hz	-133, - <i>136 dBc/Hz</i>	
≥5 MHz	N/A	N/A		-127, -129 dBc/Hz	-135, <i>-139 dBc/Hz</i>	
≥10 MHz	N/A	N/A		-131, - <i>136 dBc/Hz</i>	-137, -141 dBc/Hz	
Residual FM (peak-to	-peak)					
1 kHz RBW, 1 kHz VBW (measurement time)	1 kHz RBW, 1 kHz VBW (measurement time) $\leq 150 \text{ Hz} \times \text{N}^{\text{C}}$ (100 ms) $\leq 30 \text{ Hz} \times \text{N}^{\text{C}}$ (20 ms), Option 1DR		≤ 150 Hz x N ^C (100 ms) ≤ 10 Hz x N ^C (20 ms), Option 1DR ≤ 2 Hz peak-to-peak x N ^C , (20 ms), Option 1DR & 1D5			
Option 1D5 only 100 ms	N/A			\leq 100 Hz x N ^C		
Option 1DR only 20 ms	N/A			≤ 10 Hz x N ^C		
Option 1DR & 1D5 20 ms	1D5 N/A		≤2 Hz peak-to-peak x N ^C			
System related sideba	ands					
≥ 30 kHz offset from carrier CW signal				$\leq -65 \text{ dBc} + 20 \log N^{C}$		



Figure 1. Typical ESA-E Series performance at 1 GHz

a. Enhanced wide offset phase noise and ACPR dynamic range.

b. Add 20log(N) for frequencies > 6.7 GHz.

c. N=LO Harmonic mixing number.

d. Option 1DR is required for phase noise measurements at frequency offsets of 10 kHz and less. Performance at the 10 kHz offset without Option 1DR is –90/–94 dBc/Hz.

		E4411B	E4403B/08B	E4402B	E4404B/05B	E4407B	
	Amplitude range						
Measurem	ent range	Displ	ayed average noise	level (DANL) to ma	ximum safe input l	evel	
Input atten (5 dB step	uator range)	0 – 60 dB	0 – 65 dB	0 – 75 dB	0 – 75 dB	0 – 65 dB	
Maximum safe input level							
Input atte	nuator setting	≥ 15 dB	≥ 5 dB a	$\geq 5~\text{dB}$ average continuous power; $\geq 30~\text{dB}$ peak pulse power			
Average c	ontinuous power	inuous power +30 dBm +30 dBm (1 W) +30 dBm (1 W)					
Peak puls	e power ^a	(1 VV)	+50 dBm (100 W)	+50 dBm (100 W)			
DC	DC coupled	N/A	N/A	0 Vdc (Option UKB)	0 Vdc	0 Vdc	
voltage	AC coupled	100 Vdc +75 dBmV (0.4 W) Option 1DP	100 Vdc	100 Vdc 50 Vdc (Opt. UKB)	50 Vdc	50 Vdc (Opt. UKB)	
1 dB gain compression Two tone							
Total power at input mixer ^b 50 MHz to 6.7 GHz		0 dBm to 1.5 GHz	0 dBm				
6.7 GHz	to 13.2 GHz	46.75 dBmV (1DP)	-3 dBm				
13.2 GH	z to 26.5 GHz		-5 dBm				

< 10 µs pulse width, < 1% duty cycle. Mixer power level (dBm) = input power (dBm) minus input attenuation (dB). a. b.

	Basic analyzer		Standard analyzer		Communications test analyzer or ESA with 1DR and 1D5		
	E4411B	E4403B	E4408B	E4402B	E4404/05B/07B	E4402B	E4404/05/7B
Displayed average	noise level (dBm) (i	nput terminated, 0 dl	B attenuation, sample	e detector) spec, typi	cal		
Conditions		100 Hz RBW; 1 Hz VB	W (Option 1DR);	10 Hz RBW/1 Hz VBW (Option 1DR)		1 Hz RB (ESA with 1	W/VBW DR and 1D5)
Frequency 1 MHz - 10 MHz	-123, typ -129	typ -126	typ -129	typ -139	typ-137, -139 ^a	typ-146, -149 ^a	typ-147, -149 ^a
10 MHz - 500 MHz 500 MHz - 1 GHz	-127, typ -131 -125, typ -130	-125, typ -130	-124, typ -129	-136, typ -140	-135, typ -139		typ -149
1 GHz - 1.5 GHz 1.5 GHz - 2 GHz	-121, typ -128	-124, typ -130	-123, typ -130	-135, typ -140	-135, typ -140	typ-150	typ -150
2 GHz - 3 GHz 3 GHz - 6 GHz	NI / A	-122 typ -130	-120, typ -128	-133, typ -140	-131, typ-138		typ -148
6 GHz - 12 GHz 12 GHz - 22 GHz	N/A	N/A	-118, typ -127 -115, typ -124	N/A	-130, typ -137 -126, typ -134	N/A	typ -147 typ -144
22 GHz - 26.5 GHz		h	-109, typ -122		-125, typ-132		typ -142
Displayed average noise level (dBm) with RF preamplifier ^D							
1 IVIHZ - TU IVIHZ				typ-152	typ-155	typ -162	typ-165
TU IVIHZ - T GHZ		N/A		-152, typ -156	-151, typ -157	typ-166	typ-16/
T GHz - 2 GHz				-152, typ -156	-151, typ -155	typ - 166	typ -165
2 GHz - 3 GHz				-151, typ-154	-149, typ -152	typ -164	typ -162

a.

Custom path only, Option 120, typical. 20 to 30° C. For 0 to 55 °C range, see specifications guide. b.

	Basic analyzer	Standard analyzer or ESA with Option AYX	Communications test analyzer or ESA with Option B7D/B7E	
Display				
Display range	0.1, 0.2, 0.5 dB/division and 1 to 20 dB/division in 1 dB steps (10 display divisions)			
Log scale				
$RBW \ge 1 kHz$	Calibrated	0 to -85 dB from reference le	vel	
RBW ≤ 300 Hz	Calibrated	<u>0 to -120 dB^a from reference lev</u>	/el	
Linear scale		10 divisions		
Scale units	dBm, dBmV, dBμV, dBuA, A, V, and W	dBm, dBmV, dBμV, dBμA, A, \	/, W and Hz (Option BAA or AYQ)	
Trace detectors	Peak, neg	ative peak, sample, rms ^b , vide	o averaging	
Trace functions	Clear/write, max. h	old, min. hold, view, blank, ope	rations, normalize	
Marker readout resolution				
Log scale				
0 to - 85 dB		0.04		
0 to -120 dB (1DR)				
Linear scale		0.01% of reference level		
Reference level				
Range	—149.9 dBn	n to maximum mixer level + a	ttenuator setting	
Resolution		+0 1 dB		
Log scale				
Linear scale		\pm 0.12% of reference level		
Accuracy				
For reference level (dBm) – ir	nput attenuator setting (dB) + pre	amp gain (dB)		
-10 dBm to > -60 dBm		\pm 0.3 dB		
-60 dBm to > -85 dBm		\pm 0.5 dB		
-85 dBm to > -90 dBm		\pm 0.7 dB		
Display scale switching uncer	tainty (referenced to 1 kHz RBW at	reference level)		
Linear to log switching		\pm 0.15 dB at reference leve	91	
Resolution bandwidth switching uncertainty (referenced to 1 kHz at reference level)				
1 Hz, 3 Hz RBW	N/A	± 0.3 dB (1DR, 1D5)	± 0.3 dB (1D5)	
10 Hz, 30 Hz RBW	N/A	± 0.3 dB (1DR)	± 0.3 dB	
100 Hz, 300 Hz RBW	± 0.3 dB (1DR) ± 0.3 dB (1DR) ± 0.3 dB			
1 kHz to 3 MHz RBW		\pm 0.3 dB		
5 MHz RBW		± 0.6 dB		

a.

⁰ to -70 dB range when span = 0 Hz, or when IF gain fixed. Not available for RBW < 1 kHz or > 3 MHz. 50 Ω , accuracy (at a fixed frequency, a fixed attenuator, and referenced to -35 dBm (-10 dBm, Preamp On (Option 1DS))). b. c.

	Basic analyzer	Standard, communications test analyzer or custom configuration				
Input attenuator switching uncertainty	v (at 50 MHz)					
Attenuator setting	+ 0	.3 dB				
0 dB to 5 dB						
	Kete	erence				
15 dB	\pm (0.1 dB + 0.01 x attenuator setting)					
	*i)					
Frequency response (To dB input attenua	tion)					
Absolute ^a /typical/relative ^b 100 Hz to 9 kHz ^C	N/A	$\pm~0.5~\text{dB/NA/}\pm~0.5~\text{dB}$				
9 kHz to 3 GHz	\pm 0.5 dB/NA/ \pm 0.5 dB	\pm 0.46 dB/ \pm 0.14 dB/ \pm 0.5 dB \pm 0.5 dB/NA/ \pm 0.5 dB^a (Option UKB)				
3 GHz to 6.7 GHz	\pm 1.5 dB/NA/ \pm 1.3 dB	\pm 1.5 dB/± 0.38 dB/± 1.3 dB				
6.7 GHz to 13.2 GHz	+ 2 dB/NA/+ 1 8 dB	\pm 2 dB/ \pm 0.68 dB/ \pm 1.8 dB				
13.2 GHz to 26.5 GHz		\pm 2 dB/ \pm 0.86 dB/ \pm 1.8 dB				
Absolute amplitude accuracy						
At reference settings ^d	\pm 0.4 dB	\pm 0.34 dB, \pm 0.13 dB typical				
Preamp on	N/A	\pm 0.37 dB, \pm 0.14 dB typical				
Overall amplitude accuracy ^e	\pm (0.6dB + absolute frequency response)	\pm (0.54 dB + absolute frequency response)				
(95% confidence) ^f	N/A	± 0.4 dB (95%)				
Display scale fidelity						
Log max cumulative dB below reference level RBW ≥ 1 kHz 0 dB reference		0 dB				
> 0 to 10 dB		±0.3 dB, typ ±0.08 dB				
> 10 to 20 dB	± (U.30B + U.UT X 0B from reference level	±0.4 dB, typ ±0.09 dB				
> 20 to 30 dB		\pm 0.5 dB, typ \pm 0.1 dB				
> 30 to 40 dB		\pm 0.6 dB, typ \pm 0.23 dB				
> 40 to 50 dB		\pm 0.7 dB, typ \pm 0.35 dB				
> 50 to 60 dB		±0.7 dB, typ ±0.35 dB				
> 60 to 70 dB		±0.8 dB, typ ±0.39 dB				
> 70 to 80 dB	N/A	±0.8 dB, typ ±0.46 dB				
> 80 to 85 dB		±1.15 dB, typ ±0.79 dB				
RBW ≤ 300 Hz (Option 1DR) span > 0 Hz, auto range on 0 to 98 dB ^g	± (0.3dB + 0.01 x dB from reference level)					
> 98 to 120 dB	\pm 2.0 dB from reference level, characteristic					
Log incremental accuracy dB below reference level 0 to 80 dB ^g	± 0.4 dB / 4 dB					
Linear accuracy	± 2% of re	ference level				

Frequency response values are referenced to the amplitude at 50 MHz (20 to 30 $^{\circ}\text{C}).$ a.

b. Referenced to midpoint between highest and lowest frequency response

C.

Referenced to midpoint between highest and lowest frequency response deviations (20 to 30 °C). Custom path ESA-E only Option UKB, typical. Settings are: reference level -25 dBm; (75 Ω reference level +28.75 dBmV); input attenuation 10 dB; center frequency 50 MHz; RBW 1 kHz; VBW 1 kHz; amplitude scale linear or log; span 2 kHz; frequency scale linear; sweep time coupled, sample detector, signal at reference level. d.

For reference level 0 to -50 dBm; input attenuation 10 dB; RBW 1 kHz; e. VBW 1 kHz; amplitude scale log, log range 0 to -50 dB from reference level; frequency scale linear; sweep time coupled; signal input 0 to -50 dBm; span \leq 20 kHz. (20 to 30 °C).

10

Input frequency < 3GHz; -50 dBm \leq input power \leq 0 dBm; -50 dBm \leq reference level \leq 0 dBm; -20 dB \leq input power - ref level \leq 0 dB; input attenuation = 10 dB; 10 Hz \leq RBW \leq 1 MHz; (20 to 30 °C). Computed from the observation of a f. statistically significant number of instruments. Observations of the 50 MHz amplitude accuracy, a component of the computation of this number are performed immediately after invoking RF and IF alignments to minimize the effects of alignment drifts. 0 to 30 dB for RBW = 200 Hz.

g.

	Basic analyzer E4411B/03B/08B	Standard, communications test analyzer or customer configuration E4402B/04B/05B/07B			
Spurious responses					
Third order intermodulation distortion	For two -30 dBm signals at inpu	t mixer ^a and > 50 kHz separation			
10 MHz to 100 MHz	N/A	+7 dBm, characteristic			
100 MHz to 3 GHz		< -85 dBc, +12.5 dBm; typ +16 dBm TOI			
3.0 GHz to 6.7 GHz	$< 75 dB_{2} \pm 7.5 dB_{m} TO I$	< -82 dBc, +11 dBm; typ +18 dBm TOI			
6.7 GHz to 13.2 GHz		< -75 dBc, +7.5 dBm; typ +12 dBm TOI			
13.2 GHz to 26.5 GHz		< -75 dBc, +7.5 dBm; typ +11 dBm TOI			
Second harmonic distortion					
2 MHz to 750 MHz - 40 dBm tone at input mixer ^a	< -75 dBc, + 35 dBm SHI (E4411B)				
10 MHz to 500 MHz - 30 dBm tone at input mixer ^a	< -60 dBc, + 30 dBm SHI	< -65 dBc, + 35 dBm SHI			
500 MHz to 1.5 GHz - 30 dBm tone at input mixer ^a	< -70 dBc, + 40 dBm SHI	< -75 dBc, + 45 dBm SHI			
1.5 GHz to 2.0 GHz - 10 dBm tone at input mixer ^a	< -80 dBc, + 70 dBm SHI	< -85 dBc, + 75 dBm SHI			
> 2 GHz - 10 dBm tone at input mixer ^a	≤ -95 dBc, + 85 dBm TOI	< -100 dBc, + 90 dBm SHI			
WCDMA ACPR dynamic range ^b	Input terminated a	nd 0 dB attenuation			
Offset frequency 5 MHz	N / A	-60 dBc, -65 dBc (Opt 120), -66.5 dBc noise correction on			
10 MHz	N/A	-64.5 dBc, -65.5 dBc(Opt 120), -67 dBc noise correction on			
Other input related spurious					
Inband > 30 kHz offset	< -65 dBc for -20 dBm	tone at input mixer ^a			
Out of band responses	< -80 dBc -10 dBm to	ne at input mixer ^a			
Residual responses (Input terminated and 0 dB attenuation)					
50 Ω RF input impedance					
150 kHz to 1.5 GHz/6.7 GHz ^C	< -90 dBm				
75 Ω RF input impedance (Option 1DP only available on ESA-L Custom Configuration for the E4411B)					
1 MHz to 1.5 GHz	<-36 dBmV				
-50	- Cont				



Figure 2. Specified dynamic range for E4407B spectrum analyzer

Mixer power level (dBm) = input power (dBm) - input attenuation (dB).
 Characteristic. Measured by selecting "Measure, ACP", 20 to 30 °C, 3GPP (3.1 Dec 1999) W-CDMA signal with 1 DPCH, channel power -9 dBm/3.84 MHz, integration bandwidth 3.84 MHz, carrier frequency 2 GHz, reference level -16 dBm, input attenuation 0 dB, RBW 30 kHz. Noise correction can be turned on by selecting Measure Seture Measure, Naire Carr On

by selecting Meas Setup, More, Noise Corr On.
 c. Up to 1.5 GHz for models E4402B/03B/11B. Up to 6.7 GHz for models E4404B/05B/07B/08B.

Tracking Generator Specifications

Tracking generator Specifications (Options 1DN and 1DQ)			
Frequency range			
F4411B			
Ontion 1DN, (50 Ω)	9 kHz to 1.5 GHz		
Option 1DO, (75Ω)	1 MHz to 1.5 GHz		
E4402B/03B/04B/05B/07B/08B			
Option 1DN (50 Ω)	9 kHz to 3.0 GHz		
RBW range	1 kHz to 5 MHz		
Output power level range			
E4411B			
Option 1DN	0 to –70 dBm		
Option 1DQ	+42.75 to -27.25 dBmV		
E4402B/03B/04B/05B/07B/08B			
Option 1DN	-2 to -66 dBm		
Output vernier range			
E4411B	10 dB		
E4402B/03B/04B/05B/07B/08B	8 dB		
Output attenuator range			
E4411B	0 to 60 dB, 10 dB steps		
E4402B/03B/04B/05B/07B/08B	0 to 56 dB, 8 dB steps		
Output flatness			
E4411B			
Option 1DN, (50 W)			
9 kHz to 10 MHz	±2.0 dB		
10 MHz to 1.5 GHz	±1.5 dB		
Option 1DQ. (75 W)			
1 MHz to 10 MHz	±2.5 dB		
10 MHz to 1.5 GHz	±2.0 dB		
E4402B/03B/04B/05B/07B/08B			
9 kHz to 10 MHz	±3.0 dB		
10 MHz to 3.0 GHz	±2.0 dB		
Effective source match (characteristic)			
E4411B	< 2.5:1		
E4402B/03B/04B/05B/07B/08B	< 2.0:1 (0 dB attenuator)		
	< 1.5:1 (8 dB attenuator)		
Spurious output			
Harmonic spurs			
E4411B			
(0 dBm output)			
9 kHz to 20 MHz	<-20 dBc		
20 MHz to 1.5 GHz	<25 dBc		
E4402B/03B/04B/05B/07B/08B			
(-1 dBm output)			
20 kHz to 3 GHz	<-25 dBc		
Non-Harmonic spurs			
E4411B	<		
E4402B/03B/04B/05B/07B/08B			
9 kHz to 2 GHz	<-27 dBc		
2 GHz to 3 GHz	<-23 dBc		
Dynamic range			
Maximum output power – displayed average noise level			
Output power sweep range			
E4411B			
Option 1DN	(-15 dBm to 0 dBm) - (source attenuator setting)		
Option 1DO	(+27.75 dBmV to +42.75 dBmV) = (source attenuator setting)		
E4402B/03B/04B/05B/07B/08B			
Ontion 1DN	(-10 dBm to -2 dBm) - (source attenuator setting)		

Quasi-Peak Detector Specifications

Add a quasi-peak detector, Option AYQ, to the ESA custom analyzer configuration. Option AYQ also includes FM demodulation capability. The quasi-peak detector displays the quasi-peak amplitude of a pulse radio frequency on continuous wave signals. Amplitude response conforms with Publication 16 of Comite International Special des Perturbations Radioelectrique (CISPR) Section 1, Clause 2, as indicated in the relative quasi-peak response table.

ESA Custom configuration with Option AYQ (requires Option 1DR)						
Relative quasi-peak response to a CISPR pulse (dB)						
Pulse repetition frequency (Hz)	120 kHz EMI BW .03 to 1 GHz	9 kHz EMI BW 0.150 to 30 MHz	200 Hz EMI BW 9 kHz to 150 kHz			
1000	+8.0 ±1.0	+4.5 ±1.0				
100	0 dB reference ^a	0 dB reference ^a	+4.0 ±1.0			
60			+3.0 ±1.0			
25			0 dB reference ^a			
20	-9.0 ±1.0	-6.5 ±1.0				
10	-14 ±1.5	-10.0 ±1.5	-4.0 ±1.0			
5			-7.5 ±1.5			
2	-26 ±2.0	-20.5 ±2.0	-13.0 ±2.0			
1		-22.5 ±2.0	-17.0 ±2.0			
Isolated pulse		-23.5 ±2.0	-19.0 ±2.0			

a. Reference pulse amplitude accuracy relative a 66 μ V CW signal < 1.5 dB as specified in CISPR Pub 16 CISPR reference pulse: 0.44 μ Vs for 30 MHz to 1 GHz, 0.316 μ Vs for 150 kHz to 30 MHz, 13.5 μ Vs for 9 kHz to 150 kHz

General Specifications

	Basic analyzer		Standard, communications test analyzer or custom configuration			
	E4411B	E4403B	E4408B	E4402B	E4404/05/07B	
Temperature range						
Operating			0 °C to	o +55 °C		
Storage			-40 °C 1	to +75 °C		
Disk drive		10 °C to +40 °C				
EMI compatibility	Conducted and radiated interference is in compliance with CISPR Pub. 11/1990 Group 1 Class A Conducted and radiated interference is in compliance with CISPR Pub. 11/1990 Group 1 Class B ^a (Option 060)					
Audible noise sound pressure at 25 °C	< 40 dBa pressure and < 4.6 bels power (ISODP7779)					
Military specifications	Type tested to the environmental specifications of MIL-PRF-28800F class 3					
Power requirements		Type tested to	the environmenta	al specifications of MIL-PRF-28800F	class 3	
AC operation on (line)	90 to 132 V rms, 47 to 440 Hz 195 to 250 V rms, 47 to 66 Hz Power consumption < 300W					
Standby (line 🕁)		Power consumption < 5W				
DC operation			12 to 20 Vdc, <	200 W power consumption		
Data storage (nominal)						
Internal ^b		200 traces or states/8.0 MB				
External		3.5" 1.44 MB, MS-DOS				
Memory usage (nominal)						
State	16 kB ^C					
State plus 401- point trace	20 kB ^C					
Weight (without options)						
	13.2 kg	15.5 kg	17.1 kg	15.5 kg	17.1 kg	
Kilograms	29.1 lb	34.2 lb	37.7 lb	34.2 lb	37.7 lb	
Measurement speed						
Local measurement rate	\geq 35/sec	\geq 30/sec	≥28/sec	≥45/sec	\geq 40/sec	
Remote measurement and GPIB transfer	≥30/sec	≥30/sec	≥30/sec	≥45/sec	≥40/sec	
RF center freq tuning time	≤90 ms	\leq 90 ms	≤90 ms	\leq 75 ms	≤75 ms	
Display resolution ^d		640 x 480				

a. Meeting class A performance during DC operation.

b. For serial numbers < US414400 or MY41440000, 1MB without Option B72,

8 Mb with Option B72.

c. 401 sweep points. The size of a state will increase depending on the installed application(s). d. The LCD display is manufactured using high precision technology. However, there may be up to six bright points (white, blue, red or green in color) that constantly appear on the LCD screen. These points are normal in the manufacturing process and do not affect the measurement integrity of the product in any way.

General Specifications (continued)

Inputs/outputs				
Front panel				
Input	50 Ω type N (f); 75 Ω BNC (f) (Option 1DP); 50 Ω APC 3.5 (m) (Option BAB)			
RF out	50 Ω type N (f); 75 Ω BNC (f) (Option 1DQ)			
Probe power	+ 15 Vdc, -12.6 Vdc at 150 mA maximum (characteristic)			
External keyboard	6-pin mini-DIN, PC keyboards (for entering screen titles and file names)			
Headphone	Front panel knob controls volume			
Power output	0.2 W into 4 Ω (characteristic)			
AMPT REF out	50 Ω BNC (f) (nominal)			
IF INPUT (Option AYZ)	50Ω SMA (f) (nominal)			
LO OUTPUT (Option AYZ)	50 Ω SMA (f) (nominal)			
Rear panel				
10 MHz REF OUT	50 Ω BNC (f), > 0 dBm (characteristic)			
10 MHz REF IN	50Ω BNC (f), -15 to +10 dBm (characteristic)			
GATE TRIG/EXT TRIG IN	BNC (f). 5 V TTL			
GATE /HI SWP OUT	BNC (f). 5 V TTL			
	VGA compatible monitor, 15-pin mini D-SUB, (31,5 kHz horizontal,			
VGA UUTPUT	60 Hz vertical sync rates, non-interlaced analog RGB 640 x 480)			
IF, sweep and video ports (Option A4J or AYX)				
AUX IF OUT	BNC (f), 21.4 MHz, nominal -10 to -70 dBm (uncorrected)			
AUX VIDEO OUT	BNC (f), 0 to 1V, characteristic (uncorrected)			
HI SWP IN	BNC (f), low stops sweep, (5 V TTL)			
HI SWP OUT	BNC (f), (5 V TTL)			
SWP OUT	BNC (f), 0 to +10 V ramp			
GPIB interface(Option A4H)	IEEE-488 bus connector			
Serial interface (Option 1AX)	RS-232, 9-pin D-SUB (m)			
Parallel interface				
(Option A4H or 1AX)	25-pin D-SUB (f) printer port only			
I/O connectivity software	IO Libraries Suite (www. agilent.com/find/iosuite/data-sheet)			
Dimensions and weight for the ESA family of analyzers.				
Width to outside of instrument handle	416 mm (16.4 in.)			
Width to outside of the shipping cover	373 mm (14.7 in.)			
Overall height	222 mm (8.75 in.)			
Depth from front frame to rear frame	409 mm (16.1 in.)			
Depth with instrument handle rotated horizontal	516 mm (20.3 in.)			
E4401B/11B				
Instrument Weight	13.2 kg (29.1 lbs.)			
Shipping Weight	25.1 kg (55.4 lbs.)			
E4402B/E4403B				
Instrument Weight	15.5 kg (34.2 lbs.)			
	27.4 kg (00.4 lbs.)			
L4404B/ E4403B	17.1 kg (37.7 lbs)			
Shipping Weight	31.9 kg (70.3 lbs.)			
E4407B/08B				
Instrument Weight	17.1 kg (37.7 lbs.)			
Shipping Weight	31.9 kg (70.3 lbs.)			

Option Ordering

For information on ordering options, please refer to the *ESA/EMC Spectrum Analyzer Configuration Guide*, literature number 5968-3412E.

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